



Gate Turn-off Thyristor

DS4099-5 January 2014 (LN31739)

FEATURES

- Double Side Cooling
- High Reliability In Service
- High Voltage Capability
- Fault Protection Without Fuses
- High Surge Current Capability
- Turn-off Capability Allows Reduction in Equipment Size and Weight. Low Noise Emission Reduces Acoustic Cladding Necessary For Environmental Requirements

APPLICATIONS

- Variable speed AC motor drive inverters (VSD-AC)
- Uninterruptable Power Supplies
- High Voltage Converters
- Choppers
- Welding
- Induction Heating
- DC/DC Converters

KEY PARAMETERS

V_{DRM}	2500V
$I_{T(AV)}$	225A
I _{TCM}	600A
dV _D /dt	1000V/μs
dl _⊤ /dt	300A/µs

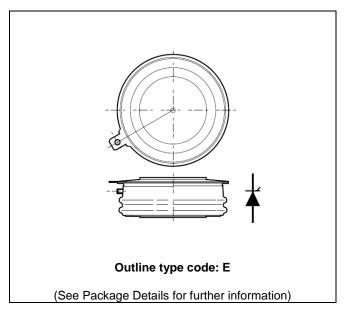


Fig. 1 Package outline

VOLTAGE RATINGS

Type Number	Repetitive Peak Off-state Voltage V _{DRM} (V)	Repetitive Peak Reverse Voltage V _{RRM} (V)	Conditions
DG306AE25	2500	16	$T_{vj} = 125$ °C, $I_{DM} = 50$ mA, $I_{RRM} = 50$ mA, $V_{RG} = 2$ V

CURRENT RATINGS

Symbol	Parameter	Conditions	Max.	Units
I _{TCM}	Repetitive peak controllable on-state current	$V_D = 67\%V_{DRM}, T_j = 125^{\circ}C,$ $dI_{GQ}/dt = 15A/\mu s, C_S = 1.0 \mu F$	600	Α
I _{T(AV)}	Mean on-state current	T _{HS} = 80°C, Double side cooled. Half sine 50Hz	225	Α
I _{T(RMS)}	RMS on-state current	T _{HS} = 80°C, Double side cooled. Half sine 50Hz	350	Α



SURGE RATINGS

Symbol	Parameter	Test Conditions	Max.	Units
I _{TSM}	Surge (non repetitive) on-state current	10ms half sine. T _j = 125°C	3.5	kA
l ² t	I ² t for fusing	10ms half sine. T _j = 125°C	61250	A ² s
di _⊤ /dt	Critical rate of rise of on-state current	$V_D = 2000V, I_T = 600A, T_j = 125^{\circ}C, I_{FG} > 20A,$ Rise time $> 1.0 \ \mu s$	300	A/μs
ما\\ /ماد		To 66% V_{DRM} ; $R_{GK} \le 1.5\Omega$, $T_j = 125^{\circ}C$	500	V/μs
dV _D /dt Rate of rise of off-state voltage	Rate of rise of off-state voltage	To 66% V_{DRM} ; $V_{RG} \le -2V$, $T_j = 125$ °C	1000	V/μs
Ls	Peak stray inductance in snubber circuit	-	200	nH

GATE RATINGS

Symbol	Parameter	Test Conditions	Min.	Max.	Units
V_{RGM}	Peak reverse gate voltage	This value may be exceeded during turn-off	-	16	V
I _{FGM}	Peak forward gate current		-	50	А
P _{FG(AV)}	Average forward gate power		-	10	W
P_{RGM}	Peak reverse gate power		-	6	kW
di _{GQ} /dt	Rate of rise of reverse gate current		10	50	A/μs
$t_{\text{ON(min)}}$	Minimum permissible on time		20	-	μS
t _{OFF(min)}	Minimum permissible off time		40	-	μS

THERMAL AND MECHANICAL RATINGS

Symbol	Parameter	Test Conditions		Min.	Max.	Units
Thermal resistance – junction to	Double side cooled	DC	-	0.075	°C/W	
R _{th(j-hs)}	R _{th(j-hs)} heatsink surface	Single side cooled	Anode DC	-	0.12	°C/W
			Cathode DC		0.20	°C/W
R _{th(c-hs)}	Contact thermal resistance	Clamping force 6.0kN With mounting compound	Per contact		0.018	°C/W
T _{vj}	Virtual junction temperature	On-state (conducting)		-	125	°C
T _{OP} /T _{stg}	Operating junction/storage temperature range			-40	125	°C
F _m	Clamping force			5.0	6.0	kN



CHARACTERISTICS

$T_j = 125$ °C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Max.	Units
V_{TM}	On-state voltage	At 600A peak, I _{G(ON)} = 2A dc	-	2.75	V
I _{DM}	Peak off-state current	V _{DRM} = 2500V, V _{RG} = 0V	-	50	mA
I _{RRM}	Peak reverse current	At V _{RRM}	-	50	mA
V_{GT}	Gate trigger voltage	V _D = 24V, I _T = 100A, T _j = 25°C	-	0.9	V
I _{GT}	Gate trigger current	V _D = 24V, I _T = 100A, T _j = 25°C	-	1.0	Α
I _{RGM}	Reverse gate cathode current	V _{RGM} = 16V, No gate/cathode resistor	-	50	mA
E _{ON}	Turn-on energy	$V_D = 2000V,$ $I_T = 600A, dI_T/dt = 300A/\mu s$ $I_{FG} = 20A, rise time < 1.0 \mu s$	-	515	mJ
t _d	Delay time		-	1.5	μS
t _r	Rise time			3.0	μS
E _{OFF}	Turn-off energy		-	1000	mJ
t _{gs}	Storage time		-	11.4	μS
t _{gf}	Fall time	$I_T = 600A$,	-	1.5	μS
t _{gq}	Gate controlled turn-off time	$V_{DM}=2000V,$ Snubber capacitor $C_S=1.0\mu F,$ $di_{GQ}/dt=15A/\mu S$	-	12.9	μS
Q_{GQ}	Turn-off gate charge			1300	μС
Q_{GQT}	Total turn-off gate charge			2600	μС
I _{GQM}	Peak reverse gate current			190	Α



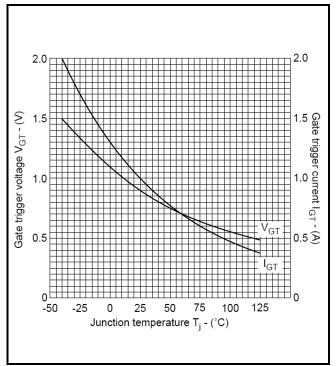


Fig.2 Maximum gate trigger voltage/current vs junction temperature

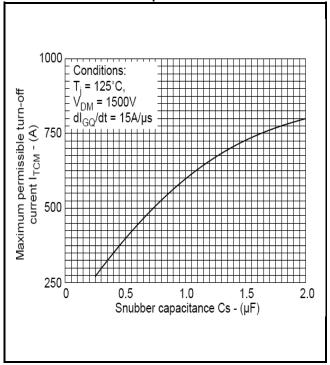


Fig.4 Maximum dependence of I_{TCM} on C_S

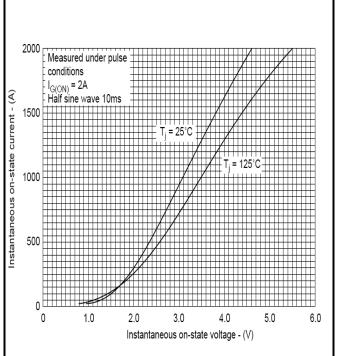


Fig.3 On-state characteristics

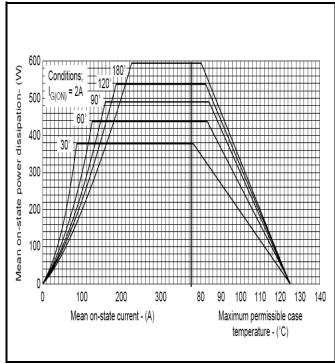
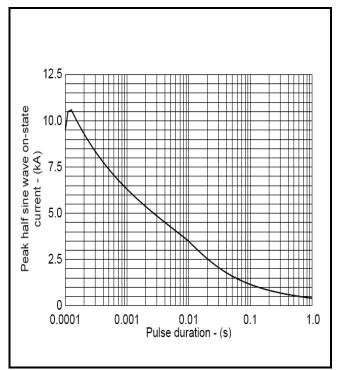
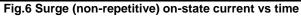


Fig.5 Steady state sinusoidal wave conduction loss – double side cooled







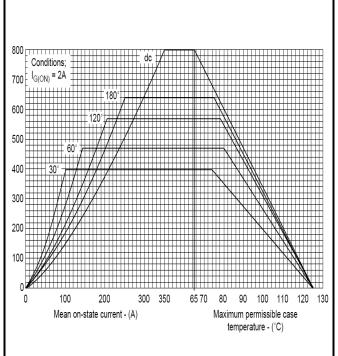


Fig.7 Steady state rectangular wave conduction loss – double side cooled

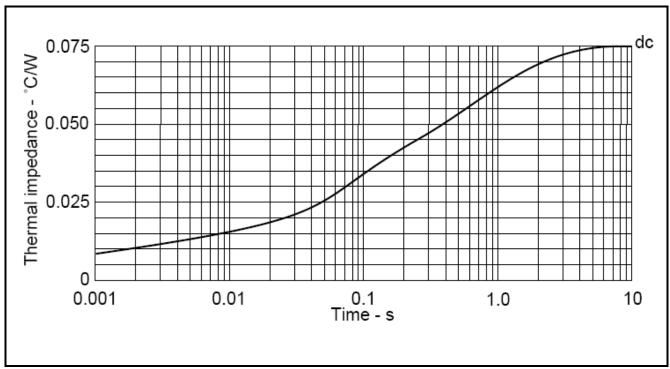


Fig.8 Maximum (limit) transient thermal impedance - junction to case (°C/kW) double side cooled



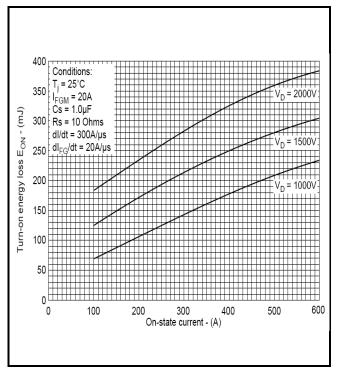


Fig.9 Turn-on energy vs on-state current

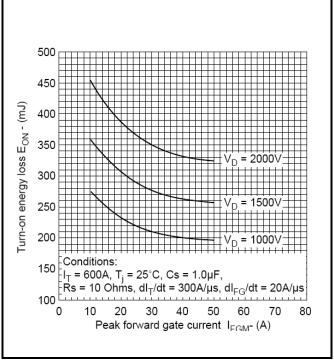


Fig.10 Turn-on energy vs peak forward gate current

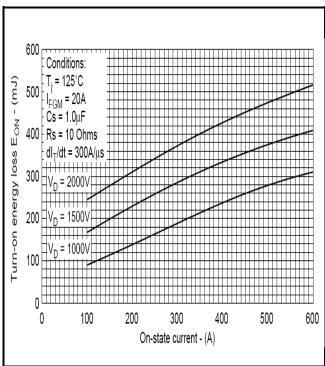


Fig.11 Turn-on energy vs on-state current

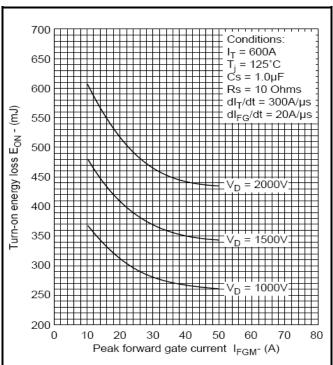
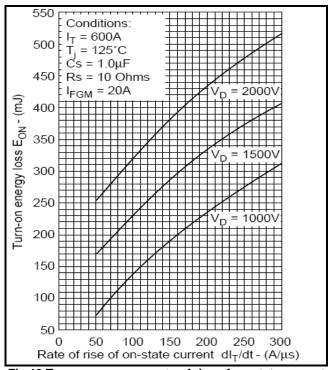
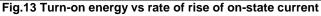


Fig.12 Turn-on energy vs peak forward gate current







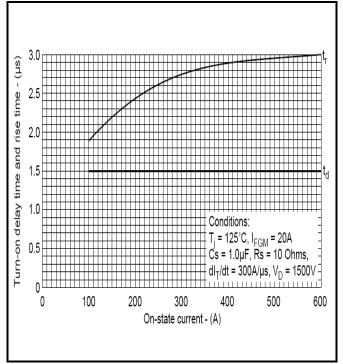


Fig.14 Delay time & rise time vs turn-on current

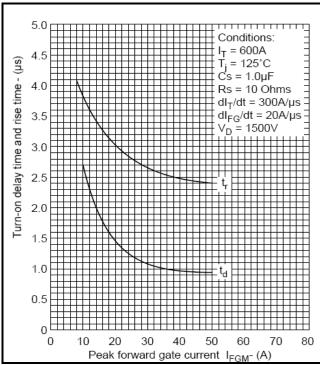


Fig.15 Delay time & rise time vs peak forward gate current

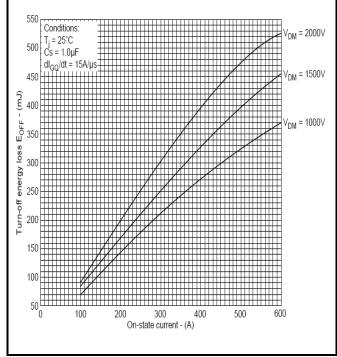


Fig.16 Turn-off energy vs on-state current



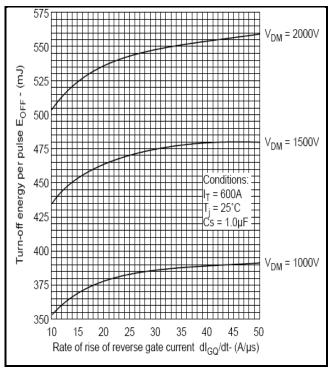


Fig.17 Turn-off energy vs rate of rise of reverse gate current

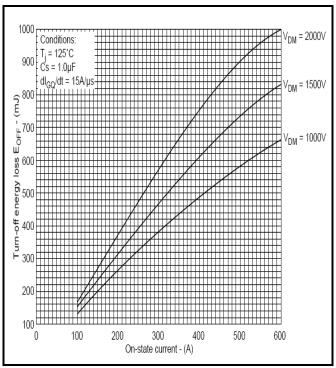


Fig.18 Turn-off energy vs on-state current

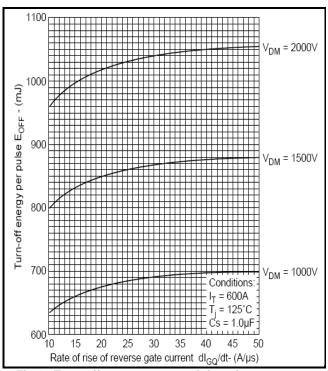


Fig.19 Turn-off energy vs rate of rise of reverse gate current

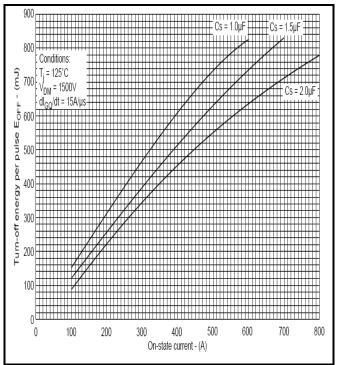


Fig.20 Turn-off energy vs on-state current



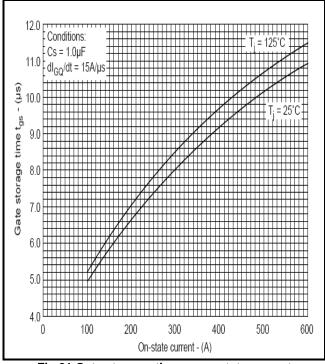


Fig.21 Gate storage time vs on-state current

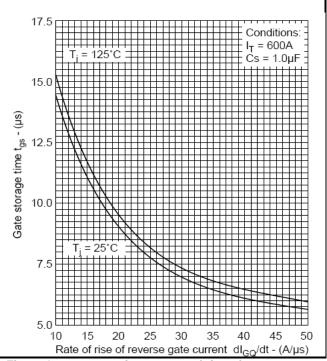


Fig.22 Gate storage time vs rate of rise of reverse gate current

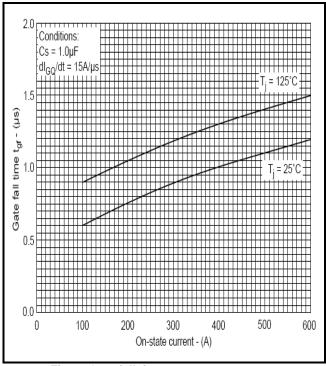


Fig.23 Gate fall time vs on-state current

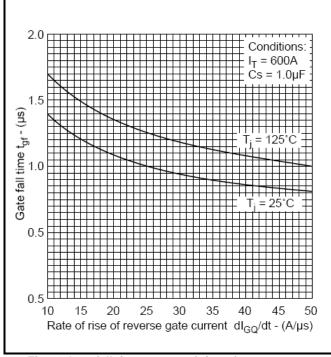


Fig.24 Gate fall time vs rate of rise of reverse gate current



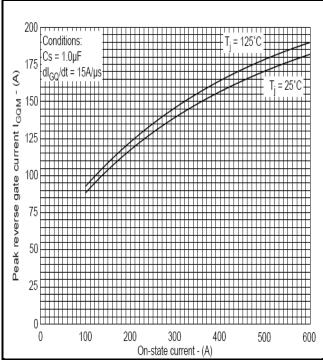


Fig.25 Peak reverse gate current vs turn-off current

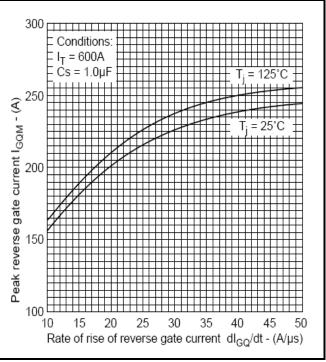


Fig.26 Peak reverse gate current vs rate of rise of reverse gate current

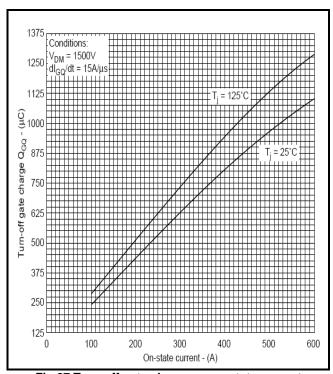


Fig.27 Turn-off gate charge vs on-state current

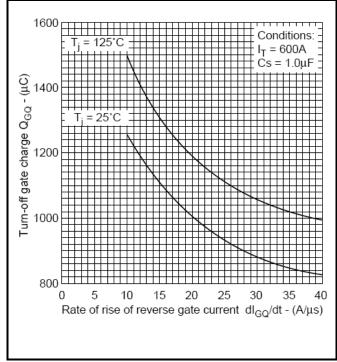


Fig.28 Turn-off gate charge vs rate of rise of reverse gate current



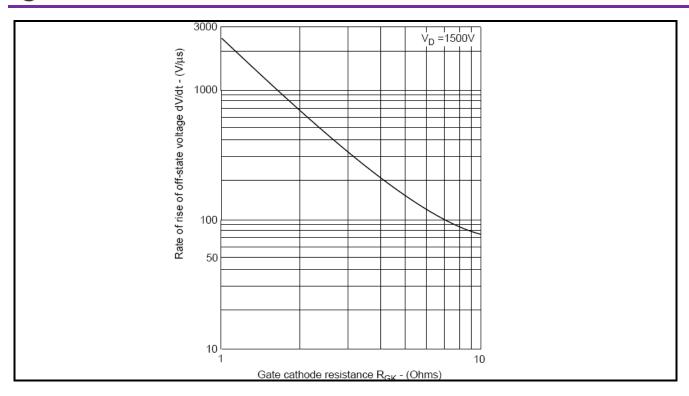


Fig.29 Rate of rise of off-state voltage vs gate cathode resistance



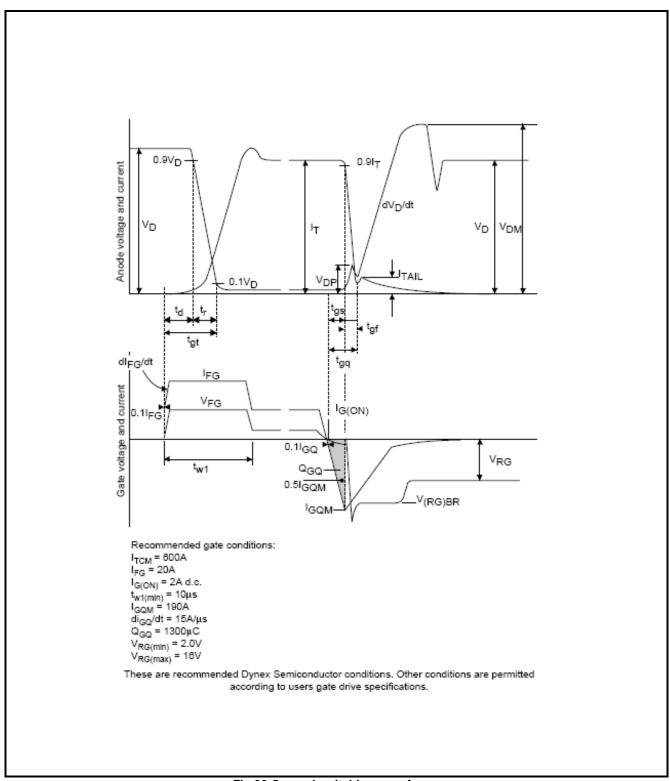


Fig.30 General switching waveforms



PACKAGE DETAILS

For further package information, please contact Customer Services. All dimensions in mm, unless stated otherwise. DO NOT SCALE.

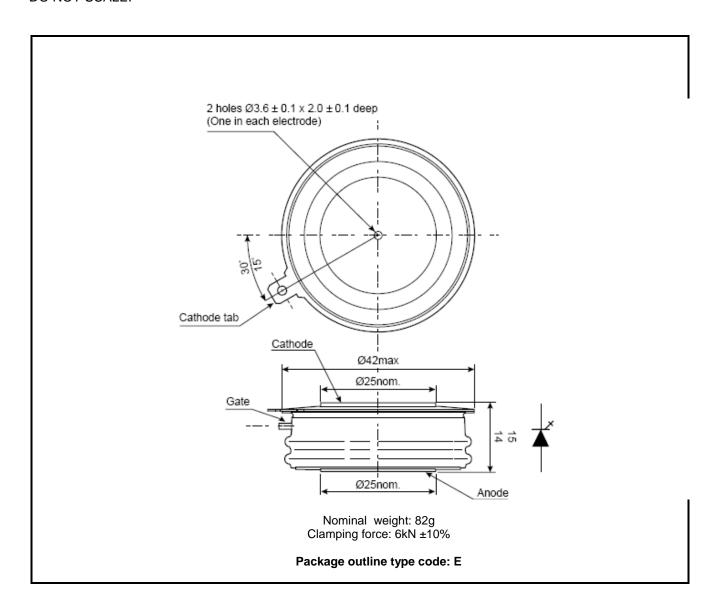


Fig.31 Package outline

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POWER ASSEMBLY CAPABILITY

The Power Assembly group was set up to provide a support service for those customers requiring more than the basic semiconductor, and has developed a flexible range of heatsink and clamping systems in line with advances in device voltages and current capability of our semiconductors.

We offer an extensive range of air and liquid cooled assemblies covering the full range of circuit designs in general use today. The Assembly group offers high quality engineering support dedicated to designing new units to satisfy the growing needs of our customers.

Using the latest CAD methods our team of design and applications engineers aim to provide the Power Assembly Complete Solution (PACs).

HEATSINKS

The Power Assembly group has its own proprietary range of extruded aluminium heatsinks which have been designed to optimise the performance of Dynex semiconductors. Data with respect to air natural, forced air and liquid cooling (with flow rates) is available on request.

For further information on device clamps, heatsinks and assemblies, please contact your nearest sales representative or Customer Services.

Stresses above those listed in this data sheet may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed.



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